## Issue Classification

App	lication	Contr	ol No
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10673631

HWANG, YONG SUK

Applicant(s)/Patent Under Reexamination

Examiner

Art Unit

Lee, Siu M

2611

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Siu M. Lee 4/18/2007 (Assistant Examiner) (Date)			Olith T						Total Claims Allowed:							
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